IN THE CLAIMS

Please enter the following amendments to the claims.

Claims 1-18 (cancelled)

19. (currently amended) A method of plating comprising:
providing <u>an</u> aqueous electroplating composition, comprising:

copper;

at least one acid, selected from sulfuric, methane sulfonic, amidosulfuric, aminoacetic, fluoboric, and mixtures thereof;

at least one halogen ion;

at least one additive, selected from an accelerating agent, a suppressing agent, and an suppressing-accelerating agent a combination of additives comprising a suppressing agent and an accelerating-suppressing agent; and

the solution and mixture products thereof:

contacting a substrate with the plating composition; and

impressing a multi-step direct-current waveform potential upon the substrate, wherein the multi-step direct current waveform potential comprises a stepped changing current density.

20. (original) The method of plating according to claim 19, wherein impressing a multi-step direct-current waveform potential upon the substrate further comprises:

applying a direct-current waveform potential upon the aqueous electroplating composition before contacting the substrate therewith.

21. (original) The method of plating according to claim 19, wherein the method further comprises:

pre-treating the substrate with a composition selected from deionized water, distilled water, an acid, a base, a solvent, a reducing agent, and mixtures thereof.

- 22. (original) The method of plating according to claim 19, wherein the contacting the substrate comprises rotating the substrate relative to the plating composition at a rate in a range from about 0 to about 500 rpm.
- 23. (original) The method of plating according to claim 19, wherein contacting the substrate comprises supplying plating composition at a rate from about 3 L/min to about 60 L/min.
- 24. (original) The method of plating according to claim 19, wherein the plating composition is maintained in a temperature range from about 7 C to about 35 C.
- 25. (original) The method of plating according to claim 19, wherein the multi-step direct current waveform potential comprises a stepped changing current density that comprises: a nucleation current density; followed by

an initiation current density; followed by

at least one cycle of a fill current density that comprises a first forward pulse

current density and a second reverse pulse current density; and followed by

a bulk fill current density.

- 26. (original) The method of plating according to claim 19, wherein the multi-step direct current waveform potential comprises a stepped increasing current density that comprises: a nucleation current density in a range from about 3 mA/cm² to about 70 mA/cm².
- 27. (original) The method of plating according to claim 19, wherein the at least one cycle of a fill current density that comprises a first forward pulse current density and a second reverse pulse current density comprises cycles in the range from 1ns to about 1 min.
- 28. (original) The method of plating according to claim 19, before contacting a substrate with the plating composition, the method further comprising:

forming a seed layer comprising copper upon the substrate, wherein forming a seed layer is selected from physical vapor deposition and chemical vapor deposition.

Claims 29 - 32 (cancelled)

If there are any additional charges, please charge Deposit Account No. 02-2666.

Respectfully submitted,

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